

**Search Notes****Application/Control No.**

10/629,131

**Applicant(s)/Patent under  
Reexamination**

YEH ET AL.

**Examiner**

HUYEN X. VO

**Art Unit**

2626

**SEARCHED**

Class	Subclass	Date	Examiner
704	270.1; 1; 9; 257; 270	9/1/2008	HV
715	208; 239	9/1/2008	HV
715	205	9/1/2008	HV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
704	270; 257	9/1/2008	HV
704	1; 9	9/1/2008	HV
715	208; 239	9/1/2008	HV
	715/205	9/1/2008	HV

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Update EAST search; google scholar, and IEEE	9/1/2008	HV